

<b>Notice of References Cited</b>	Application/Control No. 10/760,426	Applicant(s)/Patent Under Reexamination MUTOH, MASAHIKO	
	Examiner Sam K. Ahn	Art Unit 2611	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,610,939	03-1997	Takahashi et al.	375/150
*	B	US-5,774,494	06-1998	Sawahashi et al.	375/152
*	C	US-6,741,667	05-2004	Suda, Kei	375/354
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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